

Search Notes

Application/Control No.

10/522,681

Examiner

Luan K. Bui

Applicant(s)/Patent under
Reexamination

NISHIO, MITSUHIRA

Art Unit

3728

SEARCHED

Class	Subclass	Date	Examiner
206	213.1	2/2/2007	LKB
	219-220		
	438, 568		
53	432-434		
	455, 512		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR